## Supporting information Low Thermal Conductivity of Al-doped ZnO with Layered and Correlated Grain

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Figure. S1 (a) SEM micrographs from ZnO particles synthesized by sol-gel process; (b) Particle size distribution from ZnO- x%Al (x=0, 1, 2, 3) nanoparticles synthesized by sol-gel process.



Figure. S2 Cross-sectional SEM micrographs of ZnO-Al bulk pellets after sintering under 10<sup>-2</sup> Torr (a) ZnO-1%Al, (b) ZnO-2%Al, (c) ZnO-3%Al.



Figure. S3 SEM micrographs from inside surface of quartz tube (10<sup>-5</sup> Torr, 900°C) and corresponding elemental analysis is listed in Table 1.

Table S1 Elemental analysis from the inside surface of quartz tube (10-5 Torr, 900°C) by EDS point scan. The image is shown in Figure S3.

Location	O (Atomic%)	Si (Atomic%)	Zn (Atomic%)
Spectrum 1	59.69	15.21	25.10
Spectrum 2	57.64	15.47	26.89
Spectrum 3	58.26	-	41.74
Spectrum 4	53.24	-	46.76



Figure. S4 XRD of ZnO-2%Al bulk pellets after sintering at 800, 900, 1000, 1100°C in (a) 10<sup>-5</sup> Torr, and (b) Nitrogen. The XRD data are normalized. (c) SEM micrographs of second phase nano-precipitates on the surface of ZnO grain (ZnO-2%Al bulk pellet).